# **ON Semiconductor**

# Is Now



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# MOSFET - Power, Dual N- & P-Channel, μ8FL

100 V, 70 mΩ, 9.5 A, -100 V, 186 mΩ, -5 A

# NTTBC070NP10M5L

#### **Features**

- Small Footprint (3 x 3 mm) for Compact Design
- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Q<sub>G</sub> and Capacitance to Minimize Driver Losses
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

## **Typical Applications**

- Power Tools, Battery Operated Vacuums
- UAV/Drones, Material Handling
- Motor Drive, Home Automation

## MAXIMUM RATINGS (T<sub>J</sub> = 25°C, Unless otherwise specified)

Pai	Parameter			Q1	Q2	Unit
Drain-to-Source	Breakdow	n Voltage	V <sub>(BR)DSS</sub>	100	-100	٧
Gate-to-Source	/oltage		$V_{GS}$	±20	±20	٧
$\begin{array}{c} \text{Continuous} \\ \text{Drain Current} \\ \text{R}_{\theta JC} \text{ (Note 2)} \end{array}$	Steady State	T <sub>C</sub> = 25°C	I <sub>D</sub>	9.5	-5	Α
Power Dissipation $R_{\theta JC}$ (Note 2)			P <sub>D</sub>	14	10	W
Continuous Drain Current R <sub>0JA</sub> (Note 1, 2)	Steady State	T <sub>A</sub> = 25°C	I <sub>D</sub>	3.5	-2.2	Α
Power Dissipation $R_{\theta JA}$ (Note 1, 2)			P <sub>D</sub>	1.9	1.9	W
Pulsed Drain Current	T <sub>A</sub> = 25°0	$T_A = 25^{\circ}C, t_p = 10 \ \mu s$		33	33	Α
Operating Junction perature Range	n and Stor	age Tem-	T <sub>J</sub> , T <sub>stg</sub>	–55 to	+150	°C
Source Current (E	ce Current (Body Diode)			12	8	Α
Single Pulse Drain-to-Source Avalanche Energy (I <sub>L</sub> = 7.3 A, 7.8 A, L = 1 mH)			E <sub>AS</sub>	26	30	mJ
Lead Temperature Soldering Reflow for Soldering Purposes (1/8" from case for 10 s)			TL	260	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- 1. Surface-mounted on FR4 board using 1 in<sup>2</sup> pad size, 1 oz Cu pad.
- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

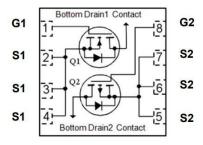


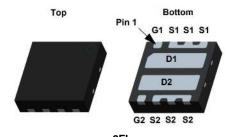
## ON Semiconductor®

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V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
100 V	70 mΩ @ 10 V	9.5 A
-100 V	186 mΩ @ 10 V	-5 A

#### **Dual-Channel MOSFET**





μ8FL CASE 511DG

# **MARKING DIAGRAM**

&Y&Z&2&K 70NP 10M5L

&Y = ON Semiconductor Logo &Z = Assembly Plant Code &2 = Numeric Date Code

&K = Lot Code

70NP10M5L = Specific Device Code

#### **ORDERING INFORMATION**

See detailed ordering and shipping information on page 10 of this data sheet.

#### THERMAL CHARACTERISTICS

Symbol	Parameter	Q1	Q2	Unit
$R_{ heta JC}$	Junction-to-Case - Steady State (Note 3)	8.9	12.5	°C/W
$R_{ hetaJA}$	Junction-to-Ambient - Steady State (Note 3)	65	65	

<sup>3.</sup> The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

# ELECTRICAL CHARACTERISTICS (Q1, N-CHANNEL) (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter	Symbol	Test Conditions		Min	Тур	Max	Unit
OFF CHARACTERISTICS					-	•	-
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		100			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> / T <sub>J</sub>	I <sub>D</sub> = 250 μA, ref to 25°C			70		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{GS} = 0 V$ , $T_J = 25^{\circ}C$				1	μΑ
		$V_{DS} = 100 \text{ V}$	V <sub>DS</sub> = 100 V T <sub>J</sub> = 125°C			100	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 V$ , $V_{GS} = 1$	±20 V			±100	nA
ON CHARACTERISTICS							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}$ , $I_D = 2$	24 μA	1.0		3.0	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> <sup>/</sup> T <sub>J</sub>	$I_D = 24 \mu A$ , ref to	25°C		7.1		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	$V_{GS}$ = 10 V, $I_D$ =	1.3A		47	70	mΩ
		$V_{GS} = 4.5 \text{ V}, I_D =$	1.0 A		67	102	
Forward Transconductance	9FS	V <sub>DS</sub> = 5 V, I <sub>D</sub> = 4 A			6.2		S
Gate-Resistance	$R_{G}$	T <sub>A</sub> = 25°C			0.74		Ω
CHARGES & CAPACITANCES					•	•	
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = 50 V			252		pF
Output Capacitance	C <sub>OSS</sub>				64		1
Reverse Transfer Capacitance	C <sub>RSS</sub>				3		
Total Gate Charge	Q <sub>G(TOT)</sub>				3		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>	., 50.			0.6		
Gate-to-Source Charge	Q <sub>GS</sub>	$V_{GS} = 4.5 \text{ V}, V_{DS} = 50 \text{ V}$	/, I <sub>D</sub> = 1.3 A		1.0		
Gate-to-Drain Charge	$Q_{GD}$				1.1		
Total Gate Charge	Q <sub>G(TOT)</sub>	., ,,,,,			5.6		
Plateau Voltage	V <sub>GP</sub>	$V_{GS} = 10 \text{ V}, V_{DD} = 50 \text{ V}$	', I <sub>D</sub> = 1.3 A		2.6		V
SWITCHING CHARACTERISTICS						-	
Turn-On Delay Time	t <sub>d(ON)</sub>				5.3		ns
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 50 V	, I <sub>D</sub> = 1.3 A.		2.5		
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$R_{G} = 6 \Omega$			12.4		
Fall Time	t <sub>f</sub>				7.5		
Turn-On Delay Time	t <sub>d(ON)</sub>				7.6		ns
Rise Time	t <sub>r</sub>	Vce = 4.5 V. Vce = 50 V	′. In = 1.3 A.		7.6		
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$V_{GS}$ = 4.5 V, $V_{DS}$ = 50 V $R_G$ = 6 $\Omega$	,,		10.4		
Fall Time	t <sub>f</sub>				9		1

# ELECTRICAL CHARACTERISTICS (Q1, N-CHANNEL) (T<sub>J</sub> = 25°C unless otherwise noted) (continued)

Parameter	Symbol	Test Conditions		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Forward Diode Voltage	$V_{SD}$	$V_{SD}$ $V_{GS} = 0 \text{ V},$ $T_{J} = 25^{\circ}\text{C}$		0.75	1.2	V	
	$V_{SD} \qquad V_{GS} = 0 \text{ V}, $ $I_{S} = 1.3 \text{ A} \qquad T_{J} = 125^{\circ}\text{C}$	T <sub>J</sub> = 125°C		0.6		1	
Reverse Recovery Time	t <sub>RR</sub>				28		ns
Charge Time	t <sub>a</sub>	$V_{GS} = 0 \text{ V, dI}_S/\text{dt}$	:= 50 A/μs,		13		1
Discharge Time	t <sub>b</sub>	$V_{GS}$ = 0 V, $dI_{S}/dt$ = 50 A/ $\mu$ s, $I_{S}$ = 1.2 A			15		
Reverse Recovery Charge	$Q_{RR}$				8		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

# **ELECTRICAL CHARACTERISTICS (Q2, P-CHANNEL)** (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter	Symbol	Test Conditions		Min	Тур	Max	Unit
OFF CHARACTERISTICS	•				-		
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$		-100			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> / T <sub>J</sub>	I <sub>D</sub> = -250 μA, ref to	) 25°C		60		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{GS} = 0 \text{ V}, V_{DS} = -100 \text{ V}$ $T_J = 25^{\circ}\text{C}$ $T_J = 125^{\circ}\text{C}$				-1	μΑ
		$V_{GS} = 0 \text{ V}, V_{DS} = -100 \text{ V}$	T <sub>J</sub> = 125°C			-100	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = ±20 V				±100	nA
ON CHARACTERISTICS	•					•	
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D = -\epsilon$	40 μΑ	-2.0		-4.0	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> / T <sub>J</sub>	I <sub>D</sub> = -40 μA, ref to	25°C		6.6		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	$V_{GS} = -10 \text{ V}, I_D = -2.2 \text{ A}$ $V_{GS} = -6 \text{ V}, I_D = -1.4 \text{ A}$			146	186	mΩ
					178	284	
Forward Transconductance	9FS	$V_{DS} = 5 \text{ V}, I_{D} = -4 \text{ A}$			5.9		S
Gate-Resistance	$R_{G}$	T <sub>A</sub> = 25°C			1.75		Ω
CHARGES & CAPACITANCES	•						
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = -50 V			256		pF
Output Capacitance	C <sub>OSS</sub>				63		
Reverse Transfer Capacitance	C <sub>RSS</sub>	1			3		
Total Gate Charge	Q <sub>G(TOT)</sub>				7.3		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>	1.,,			1.5		
Gate-to-Source Charge	$Q_{GS}$	$V_{GS} = -10 \text{ V}, V_{DS} = -50 \text{ V}$	/, I <sub>D</sub> = -2.2 A		2.4		
Gate-to-Drain Charge	$Q_{GD}$				1.2		
Total Gate Charge	Q <sub>G(TOT)</sub>				4.6		nC
Plateau Voltage	$V_{GP}$	$V_{GS} = -6 \text{ V}, V_{DD} = -50 \text{ V}, I_D = -2.2 \text{ A}$			4.5		V
SWITCHING CHARACTERISTICS	-	-			<u>-</u>	-	-
Turn-On Delay Time	t <sub>d(ON)</sub>	$V_{GS} = -10 \text{ V}, V_{DS} = -50 \text{ V}, I_D = -2.2 \text{ A},$			8.9		ns
Rise Time	t <sub>r</sub>				3.6		1
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$R_{G} = 6 \Omega$	,.,,		13.2		1
Fall Time	t <sub>f</sub>	†			3.4		1

# ELECTRICAL CHARACTERISTICS (Q2, P-CHANNEL) (T<sub>J</sub> = 25°C unless otherwise noted) (continued)

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
Turn-On Delay Time	t <sub>d(ON)</sub>			10.8		ns
Rise Time	t <sub>r</sub>	$V_{GS} = -6 \text{ V}, V_{DS} = -50 \text{ V}, I_{D} = -2.2 \text{ A},$		4.8		
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$R_G = 6 \Omega$		10		
Fall Time	t <sub>f</sub>			4.1		

#### **OFF CHARACTERISTICS**

Forward Diode Voltage	$V_{SD}$	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C	-0.86	-1.2	٧
		$V_{GS} = 0 \text{ V},$ $I_{S} = -2.2 \text{ A}$	T <sub>J</sub> = 125°C	-0.72		
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS} = 0 \text{ V, } dI_S/dt = 100 \text{ A/}\mu\text{s,}$ $I_S = -1.1 \text{ A}$		34		ns
Charge Time	t <sub>a</sub>			27		
Discharge Time	t <sub>b</sub>			7		
Reverse Recovery Charge	$Q_{RR}$			53		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

#### **TYPICAL CHARACTERISTICS - N-CHANNEL**

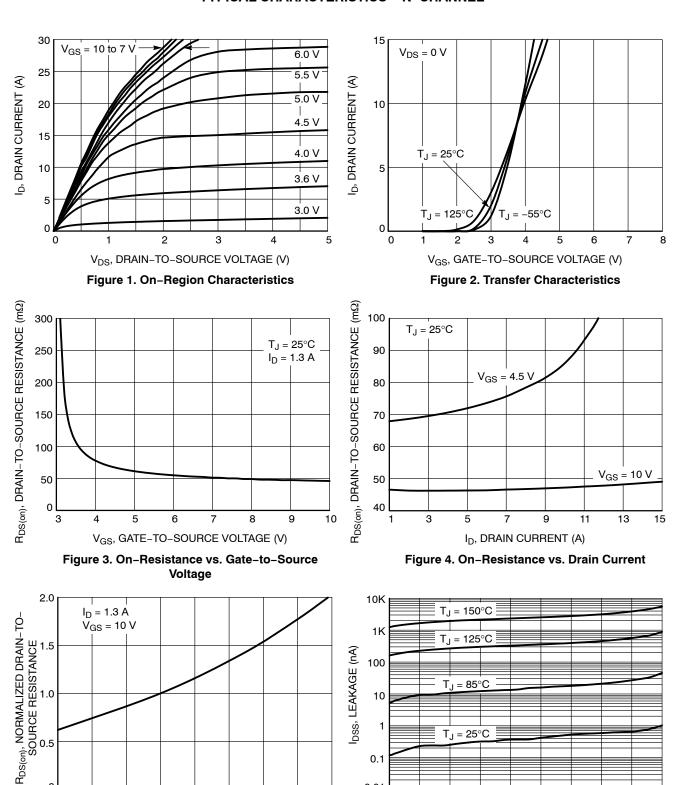


Figure 5. On-Resistance Variation with **Temperature** 

T<sub>J</sub>, JUNCTION TEMPERATURE (°C)

50

75

100

125

-50

-25

0

25

Figure 6. Drain-to-Source Leakage Current vs. Voltage

V<sub>DS</sub>, DRAIN-TO-SOURCE VOLTAGE (V)

60

80

90 100

50

 $T_J = 2\overline{5^{\circ}C}$ 

40

30

150

0.1

0.01

10

20

#### **TYPICAL CHARACTERISTICS - N-CHANNEL**

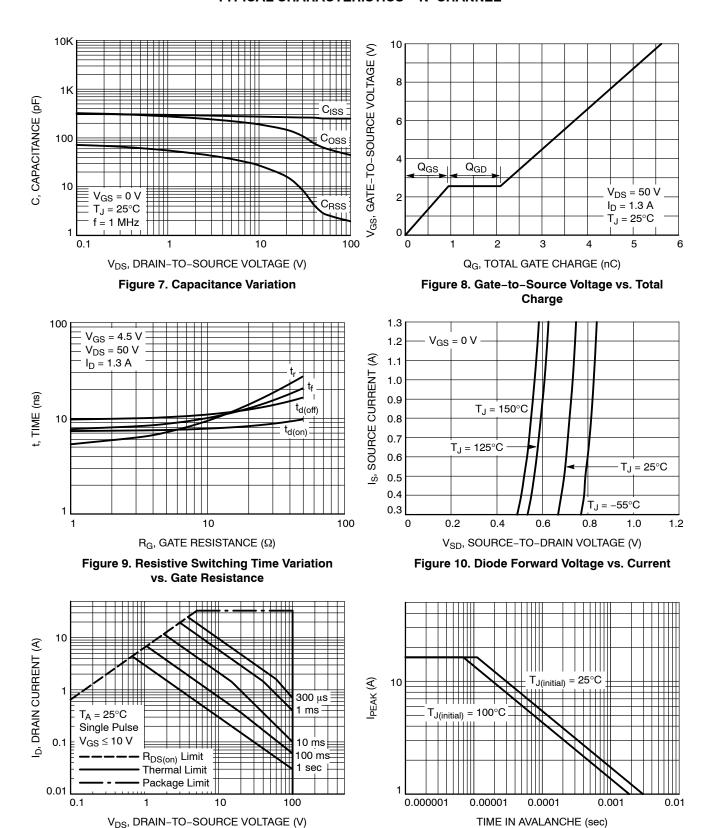


Figure 12. I<sub>PEAK</sub> vs. Time in Avalanche

Figure 11. Safe Operating Area

### **TYPICAL CHARACTERISTICS - N-CHANNEL**

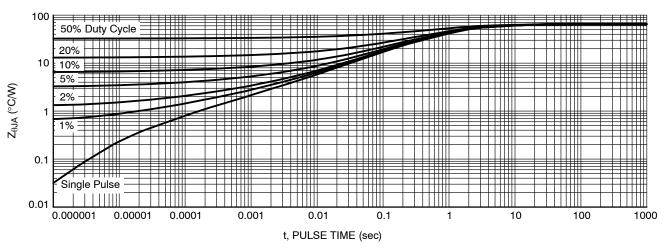


Figure 13. Junction-to-Ambient Transient Thermal Response

#### **TYPICAL CHARACTERISTICS - P-CHANNEL**

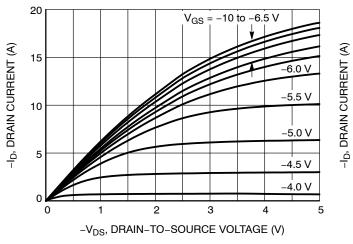


Figure 14. On-Region Characteristics

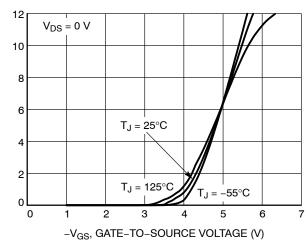


Figure 15. Transfer Characteristics

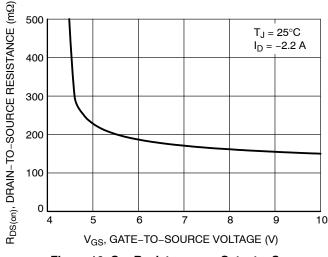


Figure 16. On-Resistance vs. Gate-to-Source Voltage

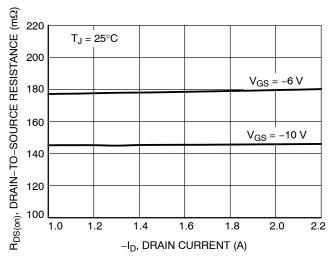


Figure 17. On-Resistance vs. Drain Current

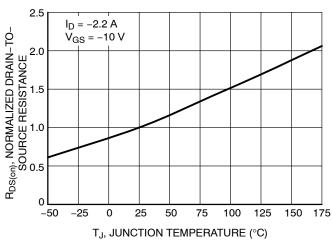


Figure 18. On-Resistance Variation with Temperature

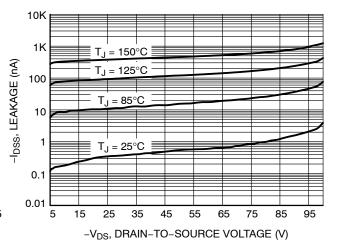


Figure 19. Drain-to-Source Leakage Current vs. Voltage

#### **TYPICAL CHARACTERISTICS - P-CHANNEL**

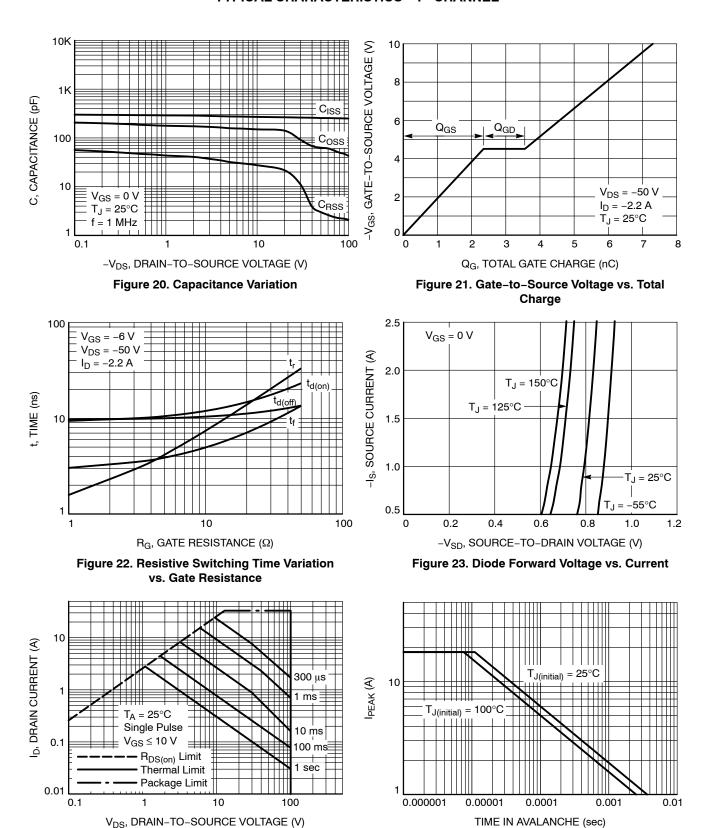


Figure 25. I<sub>PEAK</sub> vs. Time in Avalanche

Figure 24. Safe Operating Area

### **TYPICAL CHARACTERISTICS - P-CHANNEL**

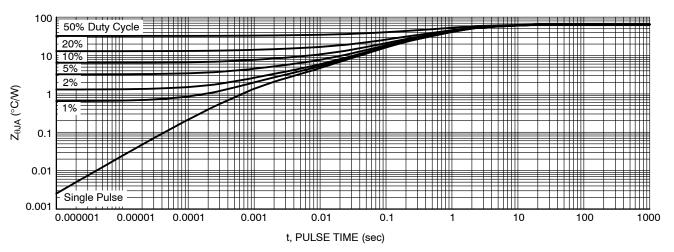


Figure 26. Junction-to-Ambient Transient Thermal Response

# **ORDERING INFORMATION**

Device	Device Marking	Package	Shipping (Qty / Packing) <sup>†</sup>
NTTBC070NP10M5L	70NP10M5L	μ8FL (Pb–Free/Halogen Free)	3000 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

#### PACKAGE DIMENSIONS

# WDFN8 3x3, 0.65P CASE 511DG **ISSUE A** B PIN DNE REFERENCE **A3** TOP VIEW DETAIL B DETAIL B // 0.10 C ○ 0.08 C SEATING NOTE 4 **PLANE** C SIDE VIEW -8X L -סמ 2X b2 4X L2 8 - (0.20)5 2X 0.755 2X E2 (0.35)

e

BOTTOM VIEW

#### NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
- CONTROLLING DIMENSION: MILLIMETERS
- DIMENSION 6 APPLIES TO PLATED TERMINALS AND IS MEASURED BETWEEN 0.15 AND 0.30MM FROM THE TERMINAL TIP.
- COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.

	MILLIMETERS					
DIM	MIN.	N□M.	MAX.			
Α	0.70	0.75	0.80			
A1	0.00		0.05			
A3		0.20 REF	-			
b	0.30	0.35	0.40			
b2	1.65 REF					
D	2.90	3.00	3.10			
D2	2.45	2.50	2.55			
E	2.90	3.00	3.10			
E2	1.40	1.50	1.60			
ŋ		0.65 BSC	;			
K	0.25					
К2	(	0.35 REF	-			
L	0.27	0.32	0.37			
L2	(	).163 REF	-			

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